Search Notes



| Application | /Control | No. |
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10563305

Applicant(s)/Patent Under Reexamination WATASE ET AL.

Art Unit

Examiner

FRANK D DUCHENEAUX

1794

SEARCHED Class Subclass Date Examiner

| SEARCH NOTES | | | | |
|---|---------|----------|--|--|
| Search Notes | Date | Examiner | | |
| PLUS search in EAST | 12/2008 | FDD | | |
| applicant prior art and fwd/backward search in EAST | 12/2008 | FDD | | |
| inventor search - limited with (carbon ADJ black) and combined citation search | 12/2008 | FDD | | |
| 428/692.1, 693.1 subclass search, text limited | 12/2008 | FDD | | |
| consulted primary examiner Kevin Bernatz | 12/2008 | FDD | | |
| consulted examiner Dhirajlal Nakarani | 12/2008 | FDD | | |
| STIC translation (Irina Knizhnik) for docs JP2002-228085, JP2002- 226783, JP2001-18322 | 12/2008 | FDD | | |

| INTERFERENCE SEARCH | | | |
|---------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
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